



TrenchStop<sup>®</sup> Series

## Low Loss IGBT in TrenchStop<sup>®</sup> and Fieldstop technology

- Best in class TO247
- Short circuit withstand time 10μs
- Designed for :
  - Frequency Converters
  - Uninterrupted Power Supply
- TrenchStop<sup>®</sup> and Fieldstop technology for 1200 V applications offers :
  - very tight parameter distribution
  - high ruggedness, temperature stable behavior
- NPT technology offers easy parallel switching capability due to positive temperature coefficient in V<sub>CE(sat)</sub>
- Low EMI
- Low Gate Charge
- Qualified according to JEDEC<sup>1</sup> for target applications
- Pb-free lead plating; RoHS compliant
- Complete product spectrum and PSpice Models : <u>http://www.infineon.com/igbt/</u>

Туре	V <sub>CE</sub>	I <sub>c</sub>	V <sub>CE(sat), Tj=25°C</sub>	<b>T</b> <sub>j,max</sub>	Marking Code	Package
IGW60T120	1200V	60A	1.7V	150°C	G60T120	PG-TO-247-3

## **Maximum Ratings**

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V <sub>CE</sub>	1200	V
DC collector current	/ <sub>C</sub>		А
$T_{\rm C} = 25^{\circ}{\rm C}$		100	
$T_{\rm C} = 90^{\circ}{\rm C}$		60	
Pulsed collector current, $t_p$ limited by $T_{jmax}$	I <sub>Cpuls</sub>	150	
Turn off safe operating area	-	150	
$V_{CE} \le 1200V, \ T_j \le 150^{\circ}C$			
Gate-emitter voltage	V <sub>GE</sub>	±20	V
Short circuit withstand time <sup>2)</sup>	t <sub>sc</sub>	10	μs
$V_{\text{GE}}$ = 15V, $V_{\text{CC}} \le$ 1200V, $T_{j} \le$ 150°C			
Power dissipation	P <sub>tot</sub>	375	W
$T_{\rm C} = 25^{\circ}{\rm C}$			
Operating junction temperature	Tj	-40+150	°C
Storage temperature	T <sub>stg</sub>	-55+150	
Soldering temperature, 1.6mm (0.063 in.) from case for 10s	-	260	

<sup>1</sup> J-STD-020 and JESD-022

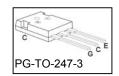
<sup>2)</sup> Allowed number of short circuits: <1000; time between short circuits: >1s.













## **Thermal Resistance**

Parameter	Symbol	Conditions	Max. Value	Unit
Characteristic				
IGBT thermal resistance,	R <sub>thJC</sub>		0.33	K/W
junction – case				
Thermal resistance,	R <sub>thJA</sub>		40	
junction – ambient				

## **Electrical Characteristic,** at $T_j$ = 25 °C, unless otherwise specified

Devemeter	Symbol	Conditions	Value			Unit
Parameter			min.	typ.	max.	Unit
Static Characteristic				-		
Collector-emitter breakdown voltage	$V_{(BR)CES}$	$V_{GE}$ =0V, $I_{C}$ =3.0mA	1200	-	-	V
Collector-emitter saturation voltage	$V_{CE(sat)}$	$V_{\rm GE}$ = 15V, $I_{\rm C}$ =60A				]
		<i>T</i> <sub>j</sub> =25°C	-	1.9	2.4	
		<i>T</i> <sub>j</sub> =125°C	-	2.1	-	
		<i>T</i> <sub>j</sub> =150°C	-	2.3	-	
Gate-emitter threshold voltage	V <sub>GE(th)</sub>	$I_{\rm C}$ =2.0mA, $V_{\rm CE}$ = $V_{\rm GE}$	5.0	5.8	6.5	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =1200V, V <sub>GE</sub> =0V				mA
		<i>T</i> <sub>j</sub> =25°C	-	-	0.6	
		<i>T</i> <sub>j</sub> =150°C	-	-	6.0	
Gate-emitter leakage current	I <sub>GES</sub>	$V_{CE} = 0V, V_{GE} = 20V$	-	-	600	nA
Transconductance	<b>g</b> <sub>fs</sub>	$V_{\rm CE}$ =20V, $I_{\rm C}$ =60A	-	30	-	S
Integrated gate resistor	R <sub>Gint</sub>			4		Ω

## **Dynamic Characteristic**

Input capacitance	Ciss	V <sub>CE</sub> =25V,	-	3700	-	pF
Output capacitance	Coss	V <sub>GE</sub> =0V,	-	180	-	
Reverse transfer capacitance	Crss	f=1MHz	-	150	-	
Gate charge	Q <sub>Gate</sub>	$V_{\rm CC}$ =960V, $I_{\rm C}$ =60A	-	280	-	nC
		V <sub>GE</sub> =15V				
Internal emitter inductance	L <sub>E</sub>		-	13	-	nH
measured 5mm (0.197 in.) from case						
Short circuit collector current <sup>1)</sup>	I <sub>C(SC)</sub>	$V_{GE} = 15V, t_{SC} \le 10\mu s$ $V_{CC} = 600V,$ $T_{j} = 25^{\circ}C$	-	300	-	A

<sup>1)</sup> Allowed number of short circuits: <1000; time between short circuits: >1s.



## Switching Characteristic, Inductive Load, at $T_i$ =25 °C

Parameter	Symbol	Conditions	Value			11
			min.	typ.	max.	Unit
IGBT Characteristic		·				
Turn-on delay time	$t_{d(on)}$	<i>T</i> <sub>j</sub> =25°C,	-	50	-	ns
Rise time	tr	$V_{CC} = 600V, I_C = 60A,$ $V_{GE} = 0/15V,$ $R_G = 10\Omega,$ $L_{\sigma}^{(2)} = 180nH,$ $C_{\sigma}^{(2)} = 39pF$ Energy losses include "tail" and diode reverse recovery.	-	44	-	1
Turn-off delay time	$t_{d(off)}$		-	480	-	
Fall time	t <sub>f</sub>		-	80	-	
Turn-on energy	Eon		-	4.3	-	mJ
Turn-off energy	E <sub>off</sub>		-	5.2	-	1
Total switching energy	Ets		-	9.5	-	1

## Switching Characteristic, Inductive Load, at T<sub>i</sub>=150 °C

Parameter	Symbol	Conditions	Value			Unit
Falameter			min.	typ.	max.	Unit
IGBT Characteristic						
Turn-on delay time	t <sub>d(on)</sub>	<i>T</i> <sub>j</sub> =150°C	-	50	-	ns
Rise time	t <sub>r</sub>	$V_{CC} = 600V, I_C = 60A,$ $V_{GE} = 0/15V,$ $R_G = 10\Omega,$ $L_{\sigma}^{(2)} = 180nH,$ $C_{\sigma}^{(2)} = 39pF$ Energy losses include "tail" and diode reverse recovery.	-	45	-	
Turn-off delay time	$t_{d(off)}$		-	600	-	
Fall time	t <sub>f</sub>		-	130	-	
Turn-on energy	Eon		-	6.4	-	mJ
Turn-off energy	Eoff		-	9.4	-	
Total switching energy	Ets		-	15.8	-	

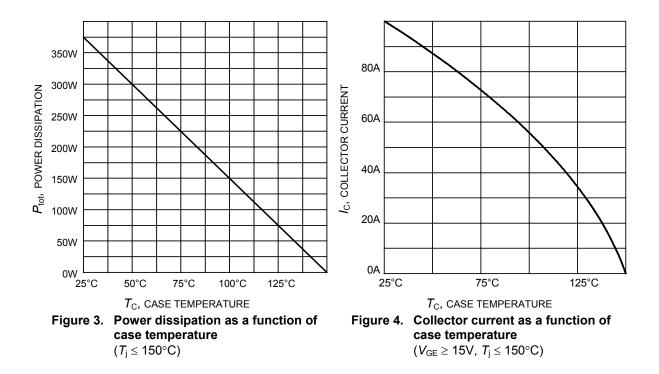
 $^{2)}$  Leakage inductance  $L_{\sigma}$  and Stray capacity  $C_{\sigma}$  due to dynamic test circuit in Figure E.



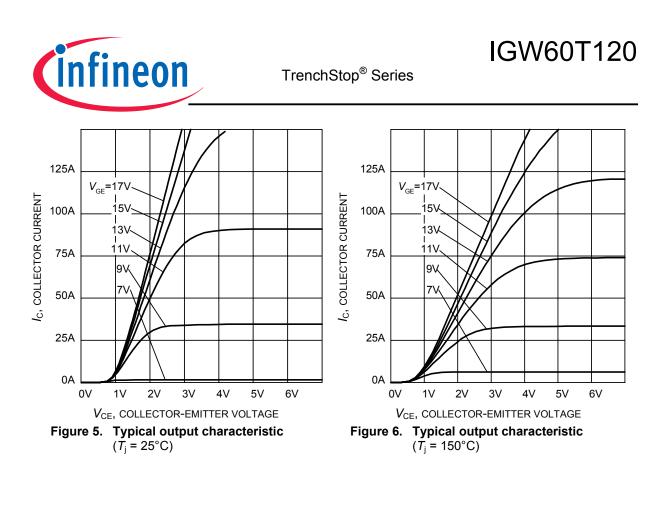
Ic, COLLECTOR CURRENT

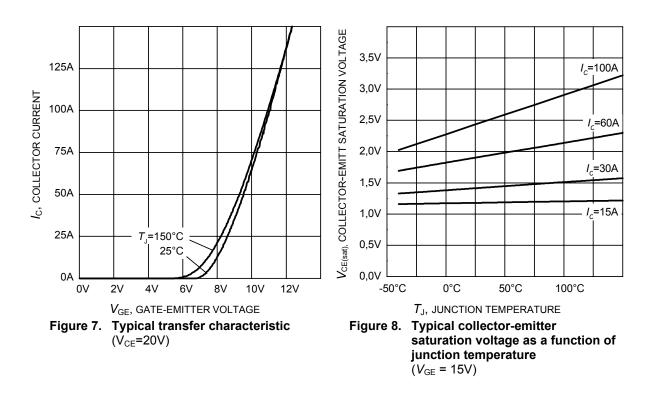
TrenchStop<sup>®</sup> Series

#### 150A ∹3µs 100A 125A 10µs 80°C 'r r r nud Ic, COLLECTOR CURRENT =110°C 100A 10A 50µs 75A 150µs 500µs 50A 1A 20ms 25A 1<sub>c</sub> DC 0,1A 0A 10Hz 100Hz 1kHz 10kHz 100kHz 1V 10V 100V 1000V $V_{CE}$ , COLLECTOR-EMITTER VOLTAGE f, SWITCHING FREQUENCY Figure 1. Collector current as a function of Figure 2. Safe operating area switching frequency $(D = 0, T_{\rm C} = 25^{\circ}{\rm C},$ ( $T_{j} \leq$ 150°C, D = 0.5, $V_{CE}$ = 600V, $T_{\rm i} \leq 150^{\circ}\rm C; V_{\rm GE} = 15V$ $V_{\rm GE} = 0/+15 V, R_{\rm G} = 10 \Omega$



**IGW60T120** 

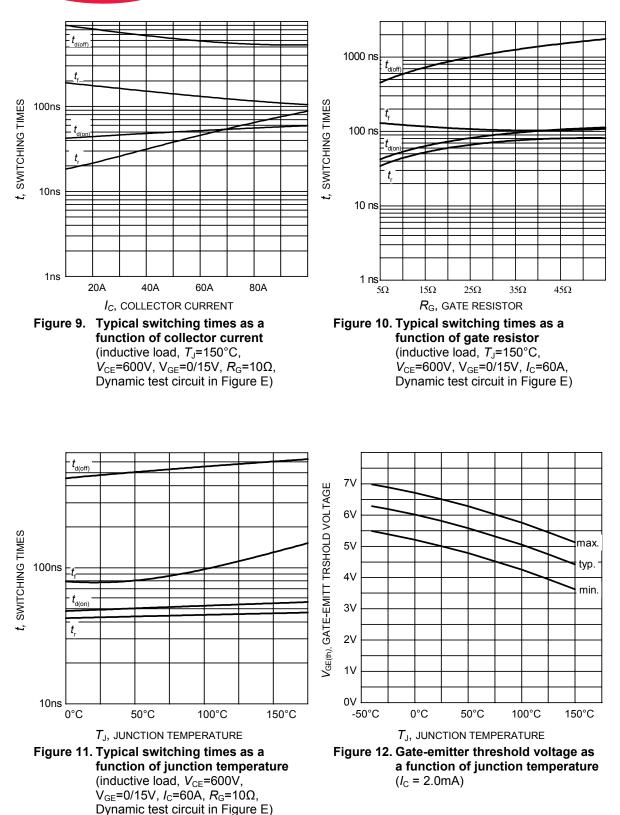




# IGW60T120



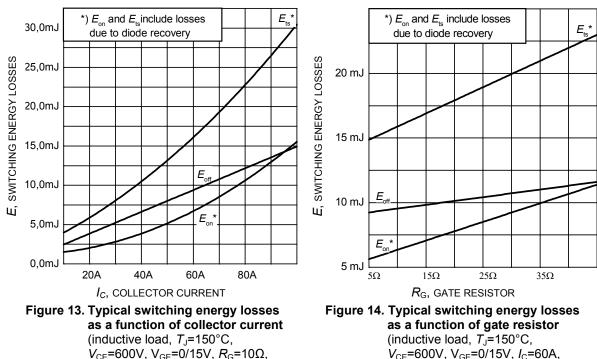
TrenchStop<sup>®</sup> Series



# IGW60T120



TrenchStop<sup>®</sup> Series



 $V_{\rm CE}$ =600V,  $V_{\rm GE}$ =0/15V,  $R_{\rm G}$ =10 $\Omega$ , Dynamic test circuit in Figure E)

100°C

\*)  $E_{on}$  and  $E_{ts}$  include losses

due to diode recovery

16mJ

14mJ

12mJ

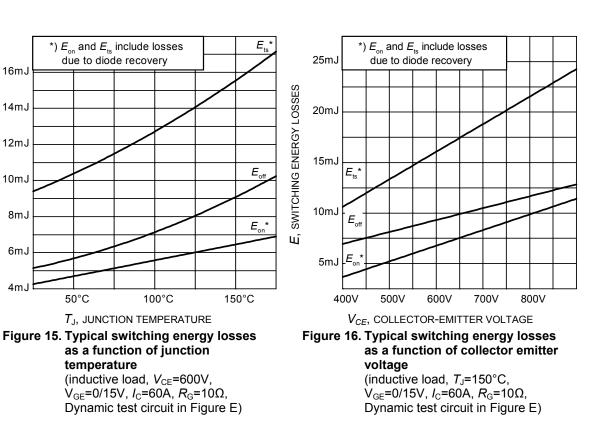
10mJ

8mJ

6mJ

4mJ

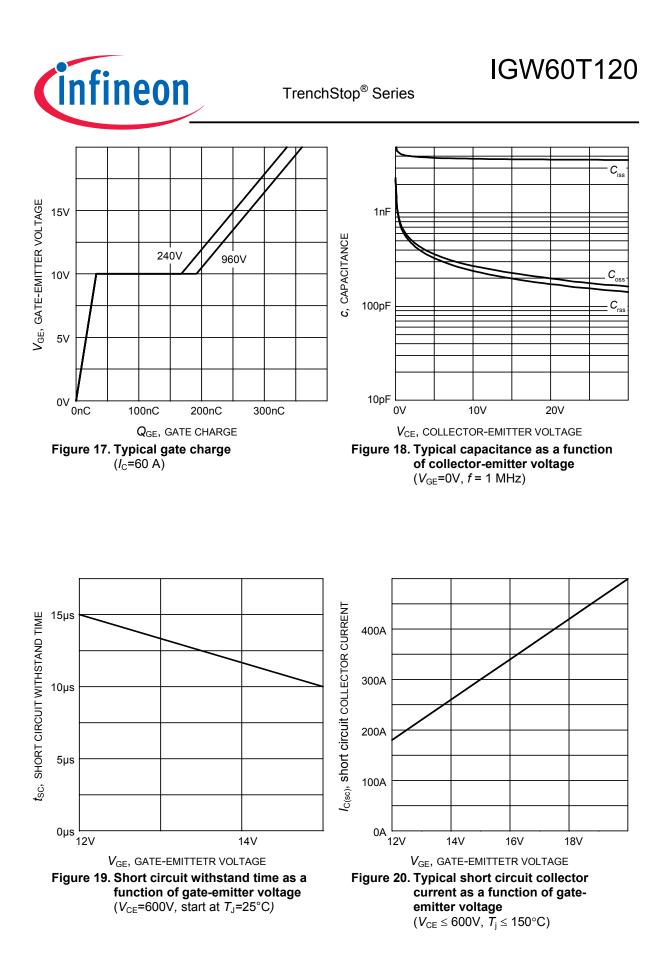
E, SWITCHING ENERGY LOSSES



Dynamic test circuit in Figure E)

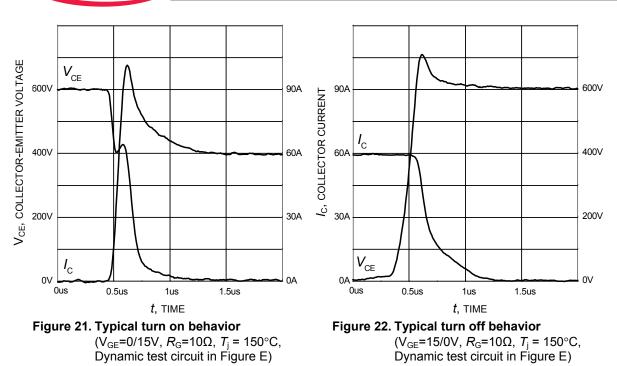
50°C

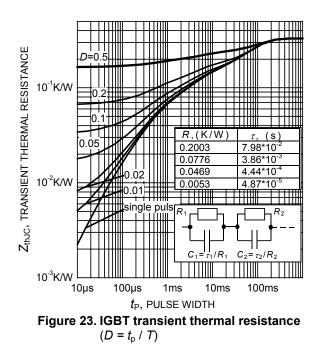
temperature





TrenchStop<sup>®</sup> Series



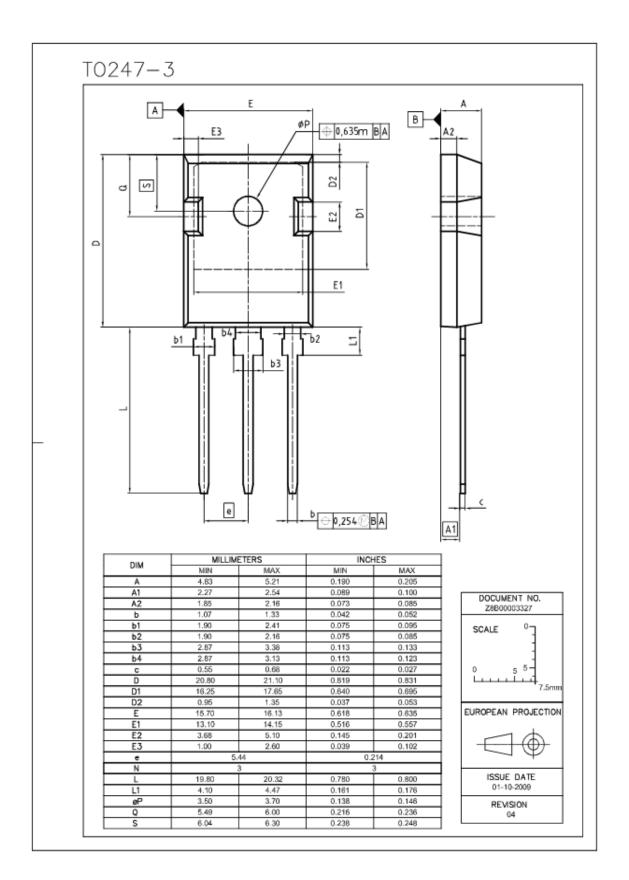


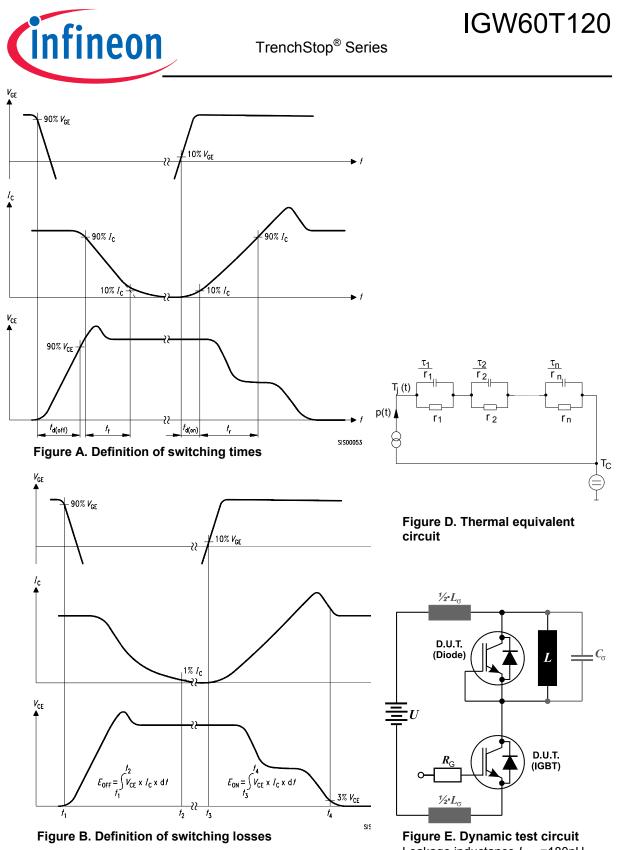
IGW60T120



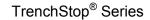


TrenchStop<sup>®</sup> Series





Leakage inductance  $L_{\sigma}$  =180nH and Stray capacity  $C_{\sigma}$  =39pF.





Edition 2006-01

Published by Infineon Technologies AG 81726 München, Germany

© Infineon Technologies AG 11/18/09. All Rights Reserved.

## Attention please!

The information given in this data sheet shall in no event be regarded as a guarantee of conditions or characteristics ("Beschaffenheitsgarantie"). With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation warranties of non-infringement of intellectual property rights of any third party.

## Information

For further information on technology, delivery terms and conditions and prices please contact your nearest Infineon Technologies Office (**www.infineon.com**).

### Warnings

Due to technical requirements components may contain dangerous substances. For information on the types in question please contact your nearest Infineon Technologies Office.

Infineon Technologies Components may only be used in life-support devices or systems with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system, or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body, or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.

IGW60T120

单击下面可查看定价,库存,交付和生命周期等信息

>>Infineon(英飞凌)